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## 1 Introduction

In recent years, perovskite solar cells (PSCs) have attracted tremendous attention,<sup>1-8</sup> since the first description by Kojima *et al.* in 2009.<sup>9</sup> Within a decade, this type of photovoltaic technology has undergone unprecedented advances in certificated power conversion efficiency (PCE), which has reached more than 20%.<sup>4-7</sup> As a result, the PSCs are considered to be highly promising candidates for reduction in the cost per watt of commercial solar-energy-conversion devices. Nevertheless, there are two dominant concerns still constraining the

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## Ambient-air-stable inorganic Cs<sub>2</sub>SnI<sub>6</sub> double perovskite thin films *via* aerosol-assisted chemical vapour deposition<sup>†</sup>

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Air-stable caesium tin iodide double perovskite (Cs<sub>2</sub>SnI<sub>6</sub>) thin films have been fabricated via aerosol-assisted chemical vapour deposition (AACVD). We compare the properties of the double perovskite films made using AACVD with those made by the widely used spin-coating method. Films with purer crystalline phase (less CsI impurity) and far better stability in ambient air can be obtained by AACVD compared with spin coating. The AACVD-grown Cs<sub>2</sub>SnI<sub>6</sub> films retain high phase purity for at least ~100 days aging in air with negligible CsI impurities detected over this time, as determined by X-ray diffraction. The films exhibit an optical band gap energy  $(E_{\alpha})$  of ca. 1.3 eV and a homogeneous morphology with the expected nominal stoichiometry within error, as probed by energy-dispersive X-ray spectroscopy. Overall, the characteristics of the Cs<sub>2</sub>SnI<sub>6</sub> films are highly process-dependent, e.g. they are influenced by the presence of hydroiodic acid (HI) in the precursor solution. Without HI addition, an iodine-deficient film with more CsI is produced, which also exhibits a larger  $E_q$  of ca. 1.6 eV. In addition to bulk properties, we utilise X-ray photoelectron spectroscopy (XPS) to scrutinise the surface characteristics in detail. We find excess Sn and I located at the surfaces. This can be attributed to the presence of Snl4 from the deposition precursor vapour. Furthermore, following aging in air, an increase in CsI impurity for the AACVD (+HI)-grown film is observed, along with a reduction in SnI<sub>4</sub> at the surfaces. Near-ambient pressure XPS (NAP-XPS) is used to examine the surface stability of AACVD (+HI)-grown films on exposure to  $O_2$  and  $H_2O$ . No enhancement in the amount of Csl impurity is observed after both  $H_2O$ vapour (9 mbar) and  $O_2$  (5 mbar) exposure. Nevertheless, the concentrations of tin and iodine change after exposure, suggesting that Snl<sub>4</sub> protects Cs<sub>2</sub>Snl<sub>6</sub> from degradation. This passivation effect of Snl<sub>4</sub> on Cs<sub>2</sub>SnI<sub>6</sub> surfaces is proposed to explain the additional stability of Cs<sub>2</sub>SnI<sub>6</sub> fabricated via AACVD.

> development of PSC commercialisation: toxicity and stability. To date, all of the most efficient PSCs have been composed of lead-containing light absorbers, potentially resulting in serious human-body and environmental damage. Consequently, developing lead-free perovskite materials for use in PSCs is preferable to reduce the toxicity of photovoltaic devices. In addition, the instability/degradation of typical perovskite materials, particularly when placed in a humid environment is extremely problematic;10 upon exposure to moisture, the most widely used organolead perovskite, methylammonium lead (tri-)iodide (MAPI), degrades into lead iodide with a complete loss of the nitrogen moiety.11 Many attempts to improve the stability of halide perovskites have been investigated by a variety of approaches, including the use of alternative lead precursors,12 mixed cations,13,14 and fabrication of two-dimensional perovskites.15 Nonetheless, the stability still lags behind industrial photovoltaic standards which typically require a <10% loss in power generation after utilisation of 20 years.<sup>16</sup> Therefore, the synthesis of stable halide perovskite films for use in photovoltaics is essential for the future development of PSCs.

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Among lead-free halide perovskite materials, tin-based perovskites are widely investigated as tin is a group IV metal and can be isoelectronic with lead. The first pure organo-Sn PSC was reported in 2014 with an initial PCE of approximately 6%.17 However, compared to organo-Pb PSCs, organo-Sn PSCs show not only lower PCEs but even poorer atmospheric stability (typically showing degradation within an hour).17 To stabilise Sn perovskites, it is possible to replace the unstable organic cation (e.g. methylammonium, MA) with inorganic metal ions such as caesium (Cs). However, the PCEs of CsSnI<sub>3</sub> PSCs are typically below 4%,18-20 with a current champion PCE of 4.8% reported recently.21 The stability with respect to oxidation is poor owing to the fact that Sn<sup>2+</sup> in CsSnI<sub>3</sub> (or MASnI<sub>3</sub> etc.) is readily oxidised to Sn<sup>4+</sup>.20 Therefore, the Sn-deficient derivative perovskite, Cs<sub>2</sub>SnI<sub>6</sub>, has been investigated as one of the most promising Pbfree light absorbers in very recent years. This is due to the tetravalent Sn in the Cs<sub>2</sub>SnI<sub>6</sub> structure, which cannot be further oxidised. As a result, the Cs<sub>2</sub>SnI<sub>6</sub> double perovskite can offer far better stability under atmospheric conditions containing oxygen and water vapour.22-30

The  $Cs_2SnI_6$  double perovskite which is ambipolar (*i.e.* it can be doped as n-type or p-type) exhibits excellent carrier mobility when doped as an n-type semiconducting material. In addition, it has a relatively low optimised energy band gap  $(E_g)$  of *ca*. 1.3 eV and high absorption coefficient (of over  $10^5$  cm<sup>-1</sup> for energies above 1.7 eV), which shows great potential for use as a light absorber in photovoltaic devices.<sup>22-24</sup> Very recently, using a special architecture, Cs<sub>2</sub>SnI<sub>6</sub>-based solar cells with PCEs of ca. 2.0% and acceptable stability in air have been reported.<sup>23</sup> By doping Br into the structure, a higher PCE of ca. 5.2% has been reported for  $Cs_2SnBr_xI_{6-x}$  (x = ~2).<sup>31</sup> Nevertheless, many discrepancies in the properties of Cs<sub>2</sub>SnI<sub>6</sub> have arisen, such as variations in  $E_{g}$  between 1.3 eV and 1.6 eV and carrier mobility (varying over the range 1–310  $\text{cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ ), which are both found to be highly process-dependent.<sup>22-25</sup> Lee et al. demonstrated that different CsI-impurity levels lead to variations in the band gap energies, carrier concentrations and mobilities, which can be controlled by preparation methods.23 Given the improvement in Pb-based perovskites, one may envisage the potential to obtain high quality Cs<sub>2</sub>SnI<sub>6</sub> thin films with favourable characteristics for use in photovoltaics using novel preparation approaches.

Aerosol-assisted chemical vapour deposition (AACVD) is a promising process for fabrication of perovskite thin films (one-step<sup>32-34</sup> and two-step processes<sup>35,36</sup>), since it merges the advantages from solution-based methods (low cost) and chemical vapour deposition (high quality, controlled thickness).<sup>37-40</sup> Nonetheless, until now, AACVD studies of halide perovskites are still limited since Lewis *et al.* first introduced AACVD-grown organo-Pb perovskite thin films.<sup>32-35</sup> A detailed study of AACVD-grown Sn-based perovskites, which includes characterisation of their bulk and surface properties and surface stability/degradation has not been reported thus far. In this work, we utilise a one-step AACVD process to fabricate high quality Cs<sub>2</sub>SnI<sub>6</sub> thin films for the first time. A thorough study of the fabrication and characterisation of Cs<sub>2</sub>SnI<sub>6</sub> material is also provided. By applying this facile, scalable process, films with high purity and uniformity can be obtained. The growth of films at a relatively low temperature of 150 °C is well adapted to flexible device applications,41-45 when compared to vacuum deposition (190 °C).25 We also demonstrate the importance of addition of hydroiodic (HI) acid to the precursor solution to afford Cs<sub>2</sub>SnI<sub>6</sub> films with a reduced number of macroscopic defects such as pinholes. Iodine vacancies (V<sub>I</sub>) are easily formed as well as tin interstitials (Sn<sub>i</sub>) in this material.<sup>29</sup> HI is selected for two reasons: firstly, it is an ideal iodine source to afford Irich Cs<sub>2</sub>SnI<sub>6</sub> material. Secondly, using excess SnI<sub>4</sub> to supply iodine could potentially lead to deleterious formation of Sn<sub>i</sub>. We also employ near-ambient pressure X-ray photoelectron spectroscopy (NAP-XPS) to measure the in situ degradation of the AACVD-grown films prepared with the addition of HI. By combining XPS data from a number of experiments, we show that surface passivation through a layer containing excess Sn and I is one factor imparting stability of the Cs<sub>2</sub>SnI<sub>6</sub> films. These insights will help the future development to Pb-free halide perovskites for use in photovoltaic devices.

### 2 Experimental

#### 2.1 Sample preparation

Firstly, 0.5196 g of caesium iodide (CsI, 99.9%, Aldrich) was added into 10 mL of warm (~70 °C) anhydrous *N*,*N*-dimethylformamide (DMF, 99.8%, Sigma-Aldrich) solvent with gentle stirring to generate a clear pale-yellow solution (0.2 M). A stoichiometric amount (0.6263 g, 0.1 M) of tin(v) iodide (SnI<sub>4</sub>, 99.999%, Aldrich) was poured into the solution. The colour of the precursor solution immediately became dark brown and then black after a few minutes. A small amount (300 µL, 0.2 M) of hydroiodic acid (HI, 57 wt%, Aldrich) was added to produce an I-rich solution (denoted as +HI). Another precursor solution was prepared without the addition of HI (denoted as -HI) for comparison. The resulting solutions were used for the AACVD process or spin-coating.

The prepared solution was directly used as the feed for AACVD without further procedures. The apparatus used for AACVD has been previously described in detail by Ramasamy et al.<sup>46</sup> Firstly, 10 mL of the DMF solution was poured into a twonecked 100 mL round-bottom flask with a gas inlet. This allows Ar carrier gas (flow rate  $\sim$ 300 sccm) to pass into the solution to support the transport of aerosol generated by a humidifier. This flask was connected to a tube in a furnace where the temperature during deposition was set to 130 °C. Indium tin oxide (ITO)coated glass (Ossila) with a size of  $2.0 \times 1.5$  cm or gold-coated silicon (Au-Si) were utilised as substrates. The deposition rate was approximately 20 nm per minute as measured by a Veeco Dektak 8 Surface Profilometer and the deposition time was set for an hour. As a result, we obtained films with a thickness of around 1.2 µm on the substrates. Following the deposition, the samples were annealed at 150 °C in ambient air to remove residual solvent from the samples and tube for 30 minutes. The sample was then allowed to cool to below 100 °C before removal from the AACVD tube. The prepared samples were placed into (sample) tubes filled with Ar and then stored in a small desiccator. For the aging study, the films were aged in ambient air at

an average relative humidity (RH) of >70% for periods up to  $\sim$ 100 days. All fresh samples were exposed to ambient air for less than 10 minutes when transferring from the growth tubes to a characterisation chamber.

A small volume (100  $\mu$ L) of the same precursor solutions (+HI) was also used to prepare spin-coated films of similar (~1.2  $\mu$ m) thickness for comparison. The films were deposited at 4000 rpm for 30 seconds and subsequently transferred to a hot plate for annealing at 150 °C in air for 30 minutes. The resultant samples were stored or aged in the same way as the AACVD-processed samples.

#### 2.2 Instrumentation

X-ray diffraction (XRD) patterns were recorded using a Bruker D8 Advance. A grazing incidence (GI) angle of 3° was used to detect the signals from the thin films without the substrates. The scanning range ( $2\theta$ ) was recorded from 5° to 80° with a step size of 0.05° and dwell time of 4.5 s.

The morphology of the films was measured using scanning electron microscopy (SEM) and bulk elemental analysis was carried out using an energy-dispersive X-ray spectroscopy (EDX, Philips XL30 equipped with a DX4 EDX spectrometer). EDX was conducted in the SEM chamber and the error in bulk stoichiometry measurements was  $\pm 2\%$ .

Optical diffuse reflectance measurements were performed using an ultra-violet-visible-near-infra-red (UV-VIS-NIR) spectrometer (PerkinElmer Lambda-1050) with an integrated sphere (IS) module to collect the scattered light. Spectra were recorded over a wavelength range of 300 to 1500 nm from samples deposited on soda-lime glass substrates. Reflectance (*R*) was automatically converted to absorption ( $\alpha$ ) data in accordance with the Kubelka–Munk equation. The optical energy band gap ( $E_g$ ) was acquired using a Tauc plot to find the onset point of the absorption spectra.

X-ray photoelectron spectroscopy (XPS) measurements were performed with either a Kratos Axis Ultra or SPECS XPS instrument. Both facilities are equipped with monochromated Al K $\alpha$  X-ray sources with a photon energy of 1486.6 eV. Emitted photoelectrons were collected using either a 165 mm hemispherical energy analyser (Kratos) or a 150 mm hemispherical energy analyser (Phoibos 150 SPECS), respectively. All measurements conducted in this section were carried out in ultra-high vacuum (UHV) conditions. Binding energies (BEs) were calibrated to C 1s from adventitious carbon at 284.8 eV for ITO-glass substrates or Au  $4f_{7/2}$  at 84.0 eV for Au–Si substrates.

The SPECS instrument also allows for NAP-XPS measurements to be carried out and the details can be found elsewhere.<sup>11</sup> The NAP cell is equipped with differential pumping to enable gas pressures up to ~15 mbar to be applied during measurement. In this work, 9 mbar water vapour (RH = ~30%) and 5 mbar oxygen were separately applied. All XPS data were analysed using CasaXPS software, in which a Shirley background and pseudo-Voigt peaks (30% Lorentzian and 70% Gaussian) were fitted to the photoelectron peaks acquired.<sup>47</sup>

BE values are quoted to an accuracy of  $\pm 0.1$  and  $\pm 0.05$  eV for typical and *in situ* XPS study, respectively, due to instrumental

precision. To obtain quantified surface compositional information, the built-in CasaXPS sensitivity factors (Kratos, relative to F 1s as 1.0) are utilised for calculating the available stoichiometry. Note that this does not allow the quantitative analysis of spectra acquired at near-ambient pressure (NAP) conditions due to the absence of adapted transmission-function data. All surface elemental concentrations are normalised to Cs (Cs  $3d_{5/2}$ spectra) as 2 in an ideal stoichiometric Cs<sub>2</sub>SnI<sub>6</sub> film. Excess concentrations of Sn and I above 1 and 6, respectively are likely to indicate the presence of non-Cs<sub>2</sub>SnI<sub>6</sub> species.

### 3 Results and discussion

Following annealing under ambient air in the AACVD reactor, highly uniform and black AACVD (+HI)-processed Cs<sub>2</sub>SnI<sub>6</sub> films were formed, as shown in Fig. 1A. This indicates strong visiblelight absorption by the as-prepared AACVD (+HI)-grown Cs<sub>2</sub>SnI<sub>6</sub> film as the part of the logo covered by the film is barely visible. Following ~100 days storage under ambient air (average RH > 70%), the appearance of the film (Fig. 1B) is similar to the fresh sample (Fig. 1A). This suggests that there is no significant change in the visible light absorption of the film after being aged in a humid environment. Peeling and scratching tests suggest that the AACVD films produced here show significantly better adhesion to the substrates than the spin-coated films prepared under similar conditions (see ESI, Fig. S1†).

In order to determine the crystalline phase, grazing incidence X-ray diffraction (GIXRD) patterns of various films (Fig. 2) were examined. Fig. 2A shows XRD reflections of a typical AACVD (+HI)-grown film as a function of aging time (up to ~100 days). For the pristine sample, the XRD peaks indicate that the crystal structure is in excellent agreement with the Cs<sub>2</sub>SnI<sub>6</sub> double perovskite structure (JCPDS no. 51-0466, cubic, space group *Fm3m*, a = 11.65 Å).<sup>26</sup> The dominant (strongest) diffraction peak from the (222) crystal plane at 26.55° and other primary peaks such as (400) are also annotated in the figure. The face-centred-cubic double perovskite structure (with Sn deficiency at the centre) increases the intensity of the (222)



Fig. 1 Photographs of an AACVD (+HI)-grown  $Cs_2Snl_6$  film on ITO-glass substrates: (A) as-deposited (B) after aging in ambient air for  ${\sim}100$  days. The thicknesses of the films are around 1.2  $\mu m.$ 



Fig. 2 XRD patterns of Cs<sub>2</sub>Snl<sub>6</sub> films on ITO-glass substrates recorded with a grazing incidence (GI) angle of 3° showing: (A) the effect of aging in air (RH > 70%) on AACVD (+HI)-processed film, (B) samples obtained from different precursor solutions and deposition processes (as annotated), and (C) the effect of aging on a spin-coated sample. The primary peaks for both Cs<sub>2</sub>Snl<sub>6</sub> and CsI are indicated; the purple dashed squares highlight the 2 $\theta$  range for the dominant (strongest) reflection of the CsI impurity. The top-right inset in each figure shows the expansion of the CsI (110) region.

reflection relative to the (111) reflection.<sup>22</sup> A more detailed examination reveals a diffraction peak due to the (110) reflection from a trace amount of the cubic CsI impurity at 27.60° (JCPDS no. 89-4257).<sup>48</sup> The amount of this contaminant is very low in fresh samples (Fig. 2A), suggesting that the AACVD process allows formation of highly pure Cs<sub>2</sub>SnI<sub>6</sub> crystalline films. In addition, we observe that the AACVD (+HI)-processed film appears to be highly stable following ~10 and ~100 days exposure to air (Fig. 2A). The amount of CsI impurity remains

low and there are no other new crystalline phases generated. The ratios of the intensity of the CsI (110) reflection to that of the  $Cs_2SnI_6$  (220) reflection are summarised in Table 1. This highlights the relatively small change in the amount of CsI impurity when aged in ambient air. As shown, the ratio is in the vicinity of ~0.020 after 100 days' aging, showing that AACVD (+HI)-processed  $Cs_2SnI_6$  is significantly more stable than the widely used methylammonium lead iodide perovskite. MAPI is easily transformed to lead iodide (PbI<sub>2</sub>) under ambient air within a week due to reaction with moisture in the environment.<sup>49</sup>

Fig. 2B shows the effect on crystal structure produced by the addition of HI in the precursor solution. In the absence of HI, a noticeable amount of CsI impurity is present  $(I_{CsI(110)}/I_{Cs,SnI_6(222)} = \sim 0.160, 10$  times more than that observed in the AACVD (+HI)-grown films, as shown in Table 1). This indicates that the synthesis process (+HI or -HI) can significantly influence the crystalline phase composition. In the relatively I-poor environment (-HI), iodine vacancies  $(V_I)$  can form more easily.<sup>29</sup> A density functional theory (DFT) study suggests V<sub>I</sub> and interstitial tin (Sn<sub>i</sub>) are the dominant defect types in Cs<sub>2</sub>SnI<sub>6</sub>.<sup>29</sup> The optimised molar concentration of HI in the precursor solution to minimise the CsI impurity phase was found to be 0.2 M, as described in the Experimental section. The concentration is roughly equivalent to twice the SnI<sub>4</sub> precursor molar concentration, in good agreement with the following reaction for formation of [SnI<sub>6</sub>]<sup>2-</sup> octahedra in Cs<sub>2</sub>SnI<sub>6</sub>:<sup>50</sup>

$$\mathrm{SnI}_4 + 2\mathrm{I}^- \to [\mathrm{SnI}_6]^{2-} \tag{1}$$

Thus it appears that excess iodine (in an I-rich environment) facilitates the formation of the  $[SnI_6]^{2-}$  sub-lattice of the Cs<sub>2</sub>SnI<sub>6</sub> double perovskite material. Not only do the different preparation methods lead to distinct phase compositions but the stability can also be affected by the thin film deposition method. The preparation route used to synthesise Cs<sub>2</sub>SnI<sub>6</sub> has been shown to be a critical factor governing its stability.<sup>25</sup> Samples prepared by spin coating were found to contain a significant CsI impurity phase after only 5 days under ambient air.22,25 Fig. 2C shows the effect of aging in ambient air on samples prepared by spin coating. There is a significant increase in CsI content with aging compared to the AACVD (+HI)-processed sample. The  $I_{CsI(110)}/I_{Cs,SnI_{c}(222)}$  ratio of the pristine spin-coated (+HI) film is attributed to a slightly higher initial impurity level ( $\sim 0.034$ ) relative to that of the pristine AACVD (+HI)-grown film. After 100 days, a substantial amount  $(\sim 0.600)$  of CsI is observed in the spin-coated film. As described, the precursor solution (+HI) and the annealing process are identical between the AACVD and spin-coating processes. Therefore, the difference in stability can be attributed to the method used to prepare the thin films. The amount of CsI appearing with time in the AACVD (+HI)-processed samples is compared with the results of Saparov et al. for films deposited by vacuum deposition in Fig. S2 (ESI<sup>†</sup>).<sup>25</sup> This suggests that the stability of the Cs<sub>2</sub>SnI<sub>6</sub> films fabricated by AACVD is comparable to or even better than that of films made via vacuum vapour deposition.<sup>25</sup> We note that the AACVD (+HI)-grown films were

Table 1 Summary of the results from characterisation of the different samples:  $I_{Cs(110)}/I_{Cs_2Snl_6(222)}$  indicates the ratios of the intensity of Csl (110) to  $Cs_2Snl_6$  (222) reflections from the XRD patterns. Elemental bulk stoichiometries (atomic) Cs/Sn and I/Sn are obtained from EDX. The optical energy bandgaps ( $E_g$ ) are acquired from Tauc plots of the absorption spectra. The ratios of Csl to  $Cs_2Snl_6$  at the surface, acquired from XPS of the Cs 3d signal (Kratos) are also shown. Note '-' means no data available

Sample ID	$I_{\rm CsI(110)}/I_{\rm Cs_2SnI6(222)}$ (XRD)	Cs/Sn (EDX)	I/Sn (EDX)	$E_{ m g}$	CsI/Cs <sub>2</sub> SnI <sub>6</sub> (XPS)	
AACVD (+HI) fresh	$0.016\pm0.002$	$2.0\pm0.1$	$6.0\pm0.2$	1.30	$0.14\pm0.01$	
AACVD (+HI) 10 days	$0.021\pm0.002$	$2.0\pm0.1$	$5.9\pm0.2$	_	_	
AACVD (+HI) 100 days	$0.024\pm0.002$	$2.0\pm0.1$	$5.8\pm0.2$	1.35	$0.20\pm0.02$	
AACVD (-HI) fresh	$0.160\pm0.020$	$1.9\pm0.1$	$5.6\pm0.2$	1.60	$0.34\pm0.03$	
Spin-coated (+HI) fresh	$0.034\pm0.003$	$2.0\pm0.1$	$5.8\pm0.2$	1.35	$0.21\pm0.02$	
Spin-coated (+HI) 10 days	$0.218\pm0.020$	$1.9\pm0.1$	$5.4\pm0.2$	_	$0.35\pm0.04$	
Spin-coated (+HI) 100 days	$0.600\pm0.060$	$1.9\pm0.1$	$\textbf{4.9} \pm \textbf{0.2}$	1.60	—	

placed in an ambient environment with higher relative humidity (R.H. > 70%) when compared to the environment in the work of Saparov and others.<sup>25</sup> These results suggest that AACVD (+HI) can produce  $Cs_2SnI_6$  double perovskite films that are stable in humid air.

Nevertheless, films prepared by both AACVD and spincoating were degraded (to a lesser or greater extent) producing CsI when aged in ambient air. This may imply a bulk decomposition mechanism:

$$Cs_2SnI_6 \rightarrow 2CsI + SnI_4.$$
 (2)

Clearly, to generate CsI by decomposition of  $Cs_2SnI_6$ ,  $SnI_4$ should be formed in accordance with this reaction. However, no peaks which can be assigned to  $SnI_4$  are observed in the XRD patterns. This may be because  $SnI_4$  is somehow absent, which we discuss in later sections. In order to determine whether the film quality could be influencing the stability of the films, the morphology of the as-prepared films was examined using SEM, as shown in Fig. 3. The crystal structures at high magnification for samples produced by AACVD (+HI), AACVD (-HI), and spincoating (+HI) are shown in Fig. 3A, C, and E, respectively. All of the samples show micrometre-sized octahedral grains; however, the average size of the grains is larger for the AACVD (+HI)- $Cs_2SnI_6$  film. The shape of the crystals in films made without HI is less well-defined, with what appears to be melted material at the surface.

SEM shows that the different processing techniques lead to differences in grain sizes. Larger grain sizes for the AACVD (+HI)-Cs<sub>2</sub>SnI<sub>6</sub> film have a lower overall surface-to-volume ratio, and are thus more resilient to atmospheric degradation partially contributing to an enhanced stability. By measuring grain sizes for the different films, we estimate that the surface area of the AACVD (+HI)-grown film (Fig. 3A) is approximately  $16 \times$  that of the film prepared by spin coating (Fig. 3E). However, the rate of degradation of the spin-coated film is *ca*.  $70 \times$  that of the AACVD (+HI)-prepared film, as estimated from XRD (Fig. S2†). This suggests that additional factors are important in determining the stability of the AACVD-prepared films.

At a lower magnification, the homogeneity of the films is shown in Fig. 3B, D, and F. The AACVD (+HI)-processed film (Fig. 3B) is very smooth, uniform, and (relatively) pin-hole free, which is important to its application as a light absorber in photovoltaic devices.<sup>51</sup> The other two samples (Fig. 3D and F, AACVD (-HI) and spin-coated (+HI) respectively) show higher roughness, less homogeneity, and more pinholes. This could also contribute to differences in the stability between AACVD and spin-coated samples. Degradation sources such as water vapour or oxygen are able to enter the bulk *via* pinholes or pores more easily. This is consistent with the rapid and more obvious degradation of the spin-coated film as measured by XRD compared to the AACVD-grown films.

The bulk stoichiometries of the films, as determined by energy-dispersive X-ray (EDX) spectroscopy, are also shown in Table 1. The AACVD (+HI)-prepared sample has the expected elemental stoichiometry of ideal  $Cs_2SnI_6$  within experimental error. The Cs : Sn ratios for all samples are very similar, and lie in the range 1.9–2.0. This suggests that if  $Cs_2SnI_6$  is converted



Fig. 3 SEM images of fresh Cs<sub>2</sub>Snl<sub>6</sub> films on ITO-glass substrates (A & B) AACVD (+HI)-processed film, (C & D) AACVD (-HI)-grown film, and (E & F) spin-coated (+HI) film at higher (A, C & E) and lower (B, D & F) magnifications.

into CsI, the CsI impurity and Sn degradation products remain in the film since it is unlikely that both are lost at the same rate. Nevertheless, the ratios of iodine to tin do show some variations, indicating a clear loss of iodine with aging for the spincoated sample. Moreover, the slight lack of iodine in the fresh AACVD (-HI)-grown sample indicates that in an I-poor environment, V<sub>I</sub> defects tend to be generated.

The optical band gap energies  $(E_{\alpha})$  of the films were determined using ultraviolet-visible-near-infrared (UV-VIS-NIR) spectroscopy. The Tauc plots (Fig. 4) were obtained from the absorption spectra transformed from the diffuse reflection spectra via the Kubelka-Munk function. Cs<sub>2</sub>SnI<sub>6</sub> is typically referred to as a direct bandgap material, which has been confirmed by photo-luminescence results.<sup>22,23,52</sup> By determining the onset of the plots, the value of  $E_{g}$  was obtained for the different samples. In Fig. 4A, we observe that the AACVD (+HI)grown Cs<sub>2</sub>SnI<sub>6</sub> film has a bandgap of ca. 1.30 eV, which is consistent with the smallest value in the range previously reported (1.3–1.6 eV).<sup>22–25,52,53</sup> Following aging for  $\sim$ 100 days, the band gap energy increases slightly to ca. 1.35 eV. More significant differences are observed in comparing films prepared with and without the addition of HI. Fig. 4B shows that the AACVD (-HI)-prepared sample has a relatively high  $E_g$  of *ca.* 1.60 eV. This again suggests that iodine deficiency or the presence of CsI impurities can significantly influence the properties of the Cs<sub>2</sub>SnI<sub>6</sub> thin films. It can be observed in Table 1 that an increase in CsI impurity level leads to higher  $E_{g}$ , in good agreement with a recent finding.<sup>23</sup> Lee et al. found that, by using spin-coating with different parameters, varying levels of CsI impurity were formed in  $Cs_2SnI_6$  films.<sup>23</sup> This results in a range of  $E_g$  values from 1.3 to 1.4 eV as well as differences in carrier concentration and mobility.23 Our study further demonstrates that the characteristics of Cs<sub>2</sub>SnI<sub>6</sub> films are highly process and defect dependent. Therefore, innovation in the preparation of Cs<sub>2</sub>SnI<sub>6</sub> films is of importance in optimising these characteristics.

These results illustrate the effects of degradation and the intrinsic differences between the bulk properties of the films prepared by various methods. The surface characteristics are equally important since degradation occurs at the solid–vapour interfaces first, where the surfaces are in contact with degradation-inducing reactants. The X-ray photoelectron



Fig. 4 Tauc plots from the UV-VIS-NIR spectra of AACVD-grown  $Cs_2SnI_6$  thin films obtained *via* the Kubelka–Munk equation by taking  $Cs_2SnI_6$  as a direct band gap semiconductor: (A) the fresh and aged AACVD-prepared film and (B) with (+HI) and without (–HI) HI addition in the precursor solutions.

spectra (XPS) shown in Fig. 5 depict the surface compositions of various fresh and aged films obtained by recording the Cs 3d core levels. Two components, giving rise to two 3d<sub>5/2.3/2</sub> doublets, are observed for all of the double perovskite samples, both fresh and aged. The higher and lower binding energy (BE) Cs 3d\_{5/2} components, located at 725.1  $\pm$  0.1 eV and 724.2  $\pm$ 0.1 eV, can be attributed to CsI and Cs<sub>2</sub>SnI<sub>6</sub>, respectively.<sup>54</sup> The assignment of the CsI features is also confirmed by comparison with spectra of a spin-coated pristine CsI film, also shown in Fig. 5. Moreover, we observed that each sample showed different surface CsI-impurity levels; spectra of films with a significant amount of CsI show pronounced high-bindingenergy shoulders in the Cs 3d peaks  $(3d_{5/2} \text{ and } 3d_{3/2})$ . In order to easily compare, the area ratios of the CsI to Cs<sub>2</sub>SnI<sub>6</sub> Cs 3d<sub>5/2</sub> components fitted are summarised in Table 1. The amount of CsI surface impurity in the AACVD (+HI)-prepared sample increases only slightly after aging for ~100 days (CsI : Cs<sub>2</sub>SnI<sub>6</sub> increases from 0.14  $\pm$  0.01 to 0.20  $\pm$  0.02). By contrast, that of the spin-coated film significantly increases (corresponding ratios  $0.21 \pm 0.02$  to  $0.35 \pm 0.04$ ) as a result of aging for a much shorter period (10 days).

This indicates the surface stability of the AACVD (+HI)-grown film is better than the spin-coated one, and this is consistent with the findings from the bulk properties. Interestingly, we observe that the CsI : Cs<sub>2</sub>SnI<sub>6</sub> ratio in the fresh sample fabricated without HI ( $0.34 \pm 0.03$ ) is similar to that of the aged spin-coated sample. These observations suggest that the presence of CsI impurity at the surfaces is strongly influenced by the preparation process. Table 1 shows that the variations between films in the relative amount of CsI impurity found at the surface are similar to the trends observed in the bulk. While we cannot directly compare the concentrations determined from XPS with



Fig. 5 XPS spectra of the Cs 3d region for various  $Cs_2Snl_6$  samples and a spin-coated CsI film for reference. All spectra are normalised to the integrated area of the overall Cs  $3d_{5/2}$  peaks ( $Cs_2Snl_6 + CsI$ ).

the ratio  $I_{\rm CsI(110)}/I_{\rm Cs_2SnI_6(222)}$  obtained from XRD, we note that for the AACVD (+HI)-grown films, the surface CsI : Cs<sub>2</sub>SnI<sub>6</sub> ratio is approximately ten times that of  $I_{\rm CsI(110)}/I_{\rm Cs_2SnI_6(222)}$ , whereas for the more degraded films this factor is lower (approximately 2– 5). This suggests that in the initial stages of degradation, CsI is localised at the film surfaces.

In addition to the amounts of CsI impurity, the stoichiometry of the other elements is of importance in understanding the surface compositions of the various films, and is shown in Table S1.† In order to easily observe deviations from stoichiometry at the surface of the films, we normalise the calculated ratios of the elements to [Cs] = 2.0 (*i.e.*  $Cs_2Sn_xI_y$ ), as for an ideal stoichiometric Cs<sub>2</sub>SnI<sub>6</sub> film. We found that all samples, whether fresh or aged, and regardless of preparation method contain excess Sn ([Sn] > 1). These Sn atoms could originate from the SnI4 precursor as we also observe excess I at the surface in all samples. For the fresh AACVD (+HI)-grown sample, the excess I is close to 4 times the excess Sn. This suggests the presence of SnI4 in significant excess, as the excess values for I and Sn are high. In addition, the amount of SnI<sub>4</sub> is far more than that of CsI, suggesting that the majority of the SnI<sub>4</sub> does not originate from the decomposition process in eqn (2). As fresh AACVDgrown films have a larger excess of I and Sn, we speculate that the residual SnI<sub>4</sub> vapour in the AACVD tube attaches to the outermost surfaces of the film. This may occur particularly during the cooling process at temperatures of  $\sim$ 100-150 °C, when the reaction between SnI4 and CsI cannot happen. The more volatile component, SnI4,<sup>50</sup> continues to be transported along the tube and condenses on the surface of the film during the cooling cycle. The relative changes in Sn concentration can also be observed in Fig. S3<sup>†</sup> by comparing the intensities of the Cs 3d<sub>5/2</sub> and Sn 3p<sub>3/2</sub> peaks.

After aging the AACVD-grown film in ambient air, the excess Sn decreases somewhat while the concentration of excess I is very significantly reduced. This suggests the SnI<sub>4</sub> at the surfaces undergoes decomposition (loss of iodine) with I2 or HI release from the film by some mechanism. SnI<sub>4</sub> is known to be easily hydrolysed in the presence of water, so the SnI4 at the surfaces is expected to react with moisture, forming hydrated SnO<sub>2</sub>  $(SnO_2 \cdot nH_2O)$ .<sup>55–58</sup> By comparison, the changes in the surface composition of the spin-coated film on aging are much smaller, starting from a smaller initial excess of Sn and I. This reinforces the suggestion that the excess SnI4 on the surfaces of the AACVD-prepared samples is due to the nature of the process. Interestingly, the fresh AACVD (-HI)-grown sample contains a very significant amount of excess Sn but a lower excess of I compared to the fresh AACVD (+HI)-prepared film, consistent with the EDX finding. The large excess of Sn could be due to a significant amount of I-deficient tin iodide, and I-deficient Sn sites within the perovskite phase. This also suggests again that without addition of HI, the formation of Cs<sub>2</sub>SnI<sub>6</sub> cannot be facilitated as per eqn (1).

It is clear that changes in surface composition of the films are observed after aging in air even for the relatively stable AACVD (+HI)-grown sample. It is therefore of interest to identify which gases in air (*e.g.*  $H_2O$  vapour or  $O_2$ ) are responsible for the surface degradation. NAP-XPS is a novel technique which allows investigation of the surface stability and degradation mechanisms of halide perovskite materials.<sup>11</sup> This is because this technique enables the surface composition of the films to be measured under near-ambient pressure (NAP) conditions in a chamber filled with specific gases, and changes during gas exposure can be determined. In this study, the effects of water vapour and oxygen were explored. The Cs 3d NAP-XPS spectra recorded from fresh AACVD (+HI)-grown Cs<sub>2</sub>SnI<sub>6</sub> films during and after exposure to O<sub>2</sub> (5 mbar) and water vapour (9 mbar, corresponding to  $\sim$ 30% RH at 25 °C) are shown in Fig. 6. The two samples were prepared from the same initial sample by cutting it into two pieces. Following water vapour exposure (Fig. 6A), we observe that the CsI component does not increase relative to Cs<sub>2</sub>SnI<sub>6</sub>. Similarly, no obvious change was found in the Cs 3d spectra before and after the film was exposed to  $O_2$ . These results suggest under those environments, the films do not degrade significantly via the mechanism in eqn (2), which should form CsI and SnI<sub>4</sub>.

This is possibly as a result of insufficient exposure time as well as the limited gas pressure in the chamber. However, as compared to similar studies of MAPI, it is clear that  $Cs_2SnI_6$  shows higher resistance to moisture when both films are exposed to environments with a RH of ~30%.<sup>11</sup> Cs remains at the surfaces of the  $Cs_2SnI_6$  film, whereas the equivalent 'A' cation in the ABX<sub>3</sub> perovskite structure of MAPI, the methyl-ammonium ion (CH<sub>3</sub>NH<sub>3</sub><sup>+</sup>), decomposes and nitrogen is lost from the surfaces of the film in the form of ammonia gas. Other



Fig. 6 NAP-XPS Cs 3d core-level spectra of AACVD (+HI)-grown films before, during, and after exposure to (A) 9 mbar  $H_2O$  vapour and (B) 5 mbar  $O_2$ . All spectra are normalised to the Cs  $3d_{5/2}$  peak areas for comparison.

Table 2Ratios of the concentrations of different components in a fresh AACVD (+HI)-prepared film determined from NAP-XPS before and after<br/>exposure to 9 mbar H<sub>2</sub>O or 5 mbar O<sub>2</sub>. All elements are normalised to [Cs] = 2.0, consistent with Table 1. Excess Sn (excess I) refers to the amount<br/>of SnI that cannot be accounted for in the Cs<sub>2</sub>SnI<sub>6</sub> (Cs<sub>2</sub>SnI<sub>6</sub> + CsI) phase(s)

Fresh AACVD (+HI)	CsI/Cs <sub>2</sub> SnI <sub>6</sub>	Total Cs	Cs in CsI	Cs in Cs <sub>2</sub> SnI <sub>6</sub>	Sn	Ι	Excess Sn	Excess I
Ideal stoichiometry	_	_	_	2	1	6	0	0
UHV before H <sub>2</sub> O exposure	$0.19\pm0.02$	$2.4\pm0.2$	$0.4\pm0.1$	$2.0\pm0.2$	$3.8\pm0.4$	$14.2\pm1.0$	$2.8\pm0.3$	$7.8 \pm 1.0$
UHV after H <sub>2</sub> O exposure	$0.17\pm0.02$	$2.3\pm0.2$	$0.3\pm0.1$	$2.0\pm0.2$	$4.5\pm0.5$	$17.4 \pm 2.0$	$3.5\pm0.4$	$11.1 \pm 1.1$
UHV before $O_2$ exposure	$0.15\pm0.02$	$2.4\pm0.2$	$0.3\pm0.1$	$2.0\pm0.2$	$1.8\pm0.2$	$9.6 \pm 1.0$	$0.8\pm0.1$	$3.3\pm0.3$
UHV after O <sub>2</sub> exposure	$\textbf{0.18} \pm \textbf{0.02}$	$2.3\pm0.2$	$0.4\pm0.1$	$2.0\pm0.2$	$2.3\pm0.2$	$9.2\pm1.0$	$1.3\pm0.1$	$\textbf{2.8} \pm \textbf{0.3}$

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core level spectra (I 3d, Sn 3d, C 1s, and O 1s) recorded from the films are shown in Fig. S4<sup>†</sup> for H<sub>2</sub>O vapour and Fig. S5<sup>†</sup> for O<sub>2</sub> exposure, respectively. In both I and Sn 3d spectra, we do not observe BE changes or new components after exposure. We note, however, that the chemical shifts between Cs<sub>2</sub>SnI<sub>6</sub>, SnI<sub>4</sub> and CsI cannot be resolved in either I 3d or Sn 3d spectra.59 In addition, the potential by-product formed by hydrolysis (SnO<sub>2</sub>- $\cdot nH_2O$ ), also has a similar Sn 3d BE to SnI<sub>4</sub> (Sn 3d<sub>5/2</sub> at BEs of  $\sim$ 487.0 eV),<sup>60-63</sup> and therefore cannot be directly observed by XPS. Nevertheless, we can observe relative changes in quantified atomic concentrations after exposure, which are summarised in Table 2. Again, we observe excess Sn and I in both fresh films although the initial stoichiometries are different. This suggests that the amount of SnI4 attaching on the film surfaces is inhomogeneous and difficult to control in the AACVD process. Nevertheless, the presence of excess Sn and I at the film surfaces is clearly revealed. For both exposure cases, the amount of Sn at the film surface increases during exposure (relative to the amount of Cs). The I concentration increases after the film is exposed to moisture, by an amount consistent with an increase in the concentration of SnI4 at the surface, whereas I is lost from the surface after exposure to O2. There are no significant changes in the amount of CsI relative to Cs<sub>2</sub>SnI<sub>6</sub> during exposure to  $H_2O$  or  $O_2$  (Table 2). Changes are observed in the O content of the surfaces, as shown in Fig. S4, S5 and Table S2;† however, simultaneous accumulation of the C 1s spectra shows that these are largely associated with surface contamination, in particular with hydroxide attached to carbon. We found high levels of hydrocarbon contamination in the fresh films (Table S2<sup>†</sup>), which can be attributed to ex situ preparation and utilisation of an organic solvent (DMF). We note that it is possible for trace carbon-containing and water contaminants to be introduced during exposure to even very pure gases in NAP-XPS,<sup>64</sup> as is suggested by Table S2.<sup>†</sup> Thus we cannot rule out the introduction of some H<sub>2</sub>O during the O<sub>2</sub>-exposure experiment.

The picture that emerges is therefore a complex one, but it is clear that the surface is unstable with respect to Sn and I content during exposure to air. All the fresh AACVD (+HI)-grown films contain an amount of CsI at the surface in excess of that observed in the bulk; however the amount of  $SnI_4$  is considerably in excess of that expected by the simple decomposition reaction in eqn (2). We therefore suggest that the initial 'fresh' surface concentrations are determined by some decomposition, beginning at grain boundaries, to give CsI and  $SnI_4$ , supplemented by an excess of Sn and I (largely as  $SnI_4$ ) from residual precursor attaching during the AACVD growth. In our experiments on surface exposure and aging, we take the results from NAP-XPS to indicate the initial stages of degradation, and those from XPS after 100 days to give information on longer-term effects. The NAP-XPS data suggest that the next stages of degradation involve an increase in surface Sn content, with some indication of further SnI<sub>4</sub> formation or migration from the bulk, while the longer term aging experiments suggest this is followed by hydrolysis of this SnI<sub>4</sub> over the longer term, accompanied by loss of I from the surface. We believe that the large excess of SnI<sub>4</sub> at the surface of the AACVD (+HI)-prepared films provides a passivation functionality that protects Cs<sub>2</sub>SnI<sub>6</sub> from degradation when exposed to air. This is reinforced by the absence of any increase (within error) in CsI concentration at the surfaces after exposure to H<sub>2</sub>O or O<sub>2</sub> in NAP-XPS, and by the rather small increase in surface and bulk concentrations after 100 days aging in air. This suggests why AACVD-grown films have better stability when they are placed in ambient air compared to those fabricated through spin coating.

To summarise, we propose the decomposition of  $Cs_2SnI_6$ occurs by the following steps: (1) initial decomposition at grain boundaries *via* eqn (2) to produce CsI and SnI<sub>4</sub>; (2) some further migration of Sn, possibly as SnI<sub>4</sub> to the outermost surfaces; (3) SnI<sub>4</sub> is consumed by hydrolysis with loss of I<sub>2</sub> or HI; (4) Cs<sub>2</sub>SnI<sub>6</sub> is re-exposed due to removal of SnI<sub>4</sub> and therefore decomposed to CsI and SnI<sub>4</sub> in air; (5) excess SnI<sub>4</sub> is consumed again *via* (3).

### 4 Conclusions

To conclude, we have successfully fabricated ambient-air-stable Cs<sub>2</sub>SnI<sub>6</sub> double perovskite films resistive to decomposition in ambient air via a novel deposition method, AACVD. Compared to spin-coating, a reduction in the amounts of CsI impurity phase in the films made by AACVD has been demonstrated. We also find that addition of HI to the precursor solution reduces not only the amount of CsI in the film but the overall iodine deficiency. Moreover, the AACVD (HI+)-grown films show superior stability in humid ambient air. No further CsI is formed at the film surface on exposure to up to 9 mbar of H<sub>2</sub>O vapour or 5 mbar O<sub>2</sub>. We find that excess SnI<sub>4</sub> present at the surfaces of AACVD (+HI)-grown films (most probably from precursor adsorption) may act as a protective layer to prevent  $Cs_2SnI_6$  from degradation. We propose the degradation proceeds by decomposition into CsI and SnI4, followed by hydrolysis and loss of the latter. Ultimately, this study provides

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an insight into novel stable-halide-perovskite fabrication and an understanding of the enhanced stability of  $Cs_2SnI_6$  films made by AACVD.

## Conflicts of interest

There are no conflicts to declare.

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